#17 Study of negative ion beam emittance characteristics using 3D PIC-MCC simulation

K. Miyamoto¹⁾, K. Nagaoka^{2), 3)}, A. Hatayama⁴⁾, K. Hoshino⁴⁾, H. Nakano^{2), 5)}, T. Shibata⁶⁾, K. Tsumori^{2), 5)}

1) Naruto University of Education, 2) NIFS, 3) Nagoya University, 4) Keio University, 5) SOKENDAI(The Graduate University for Advanced Students), 6) KEK



Introduction

A negative ion source of the neutral beam injection system for nuclear fusion is required to produce a negative ion beam

It is reported from the measurement of a negative ion beamlet emittance that the characteristic three-Gaussian components are observed in the emittance diagram [1]. These components can be identified as a combination of three beam

In order to clarify the origin of this complicated phase space structure and underlying physical mechanism, potential structure and particle dynamics including the negative ion trajectories have been calculated self-consistently in a 3D



- Beam width shows the minimum in $V_{\rm acc}/V_{\rm ex}$ scan
- Beam width also changes with arc power (perveance)







Relation between the location of the negative ion extraction along the plasma meniscus and the emittance diagram



	$V_{acc}/V_{ext} = 13$	$V_{acc}/V_{ext} = 22$	$V_{acc}/V_{ext} = 26$
Total number of the negative ion beam trajectories in the analysis	515	421	505
A number of the negative ion beam trajectories extracted from the region 1	100	87	107
A number of the negative ion beam trajectories extracted from the region 2	353	278	359
A number of the negative ion beam trajectories extracted from the region 3	62	56	39

It is shown that the Gaussian components are caused by the negative ions extracted from the different plasma meniscus region, that is, the central region or the region near the edges of the meniscus.







Dependence of the peak shift of the negative ion beam component profile on V_{acc}/V_{ext}



The peaks of the negative ion beam components extracted from the meniscus region 1 and 3 shift in the opposite direction each other as the voltage ratio V_{acc}/V_{ext} increases.

Spatial profile of the negative ion beam component extracted from the meniscus region 1



Spatial profile of the negative ion beam component extracted from the meniscus region 3



Summary

- 1) It is verified that the negative ion beam changes from a diverging beam to a converging beam due to a electrostatic lens effect as the voltage ratio V_{acc}/V_{ext} increases.
- 2) It is shown that the Gaussian components are caused by the negative ions extracted from the different plasma meniscus region, that is, the central region or the region near the edges of the meniscus.
- 3) The peaks of the negative ion beam components extracted from the upper and lower meniscus region shift in the opposite direction each other as the voltage ratio V_{acc}/V_{ext} increases, which corresponds that the negative ion beam changes from the diverging beam to the converging beam.
- 4) The number of the negative ion trajectories extracted from the upper meniscus region is not the same as that extracted from the lower meniscus, which reflects that the negative ion density spatial profile is not symmetry with the axis.
- 5) It is considered that the asymmetry of the plasma meniscus results from that of the negative ion density spatial profile.